National Accreditation Board for Testing and Calibration Laboratories

SCOPE OF ACCREDITATION

Laboratory Name :	MFR ELECTRONICS TEST LABORATORY, UNIT NO 40, SDF II, SEEPZ (SEZ) ANDHERI (EAST), MUMBAI, MAHARASHTRA, INDIA		
Accreditation Standard	ISO/IEC 17025:2017		
Certificate Number	TC-10310	**Page No**	1 of 16
Validity	15/02/2022 to 14/02/2024	**Last Amended on**	19/05/2023

S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
Permanent Facility				
1	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE MEASUREMENT	IS 5786 (PART 1):: Method : 8.3.1
2	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE MEASUREMENT	IS 8909 (PART 2 & 3); Method : 8.3.1
3	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE MEASUREMENT	IS 9437:1980 (PART2 & 3); Method : 8.3.1
4	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE MEASUREMENT	JSS 50401 (Test No. 13.2)
5	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE MEASUREMENT	JSS 50402 (Test No. 13.2)
6	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE MEASUREMENT	JSS 5905-02 (Test No. 13.2)
7	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE MEASUREMENT	MIL/PRF/39017G:: Method : 4.8.3
8	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE MEASUREMENT	MIL/PRF/55182H:: Method : 4.8.5

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9	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DC RESISTANCE OF RESISTORS	JSS 50403 (Test No. 13.2)
10	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DIELECTRIC WITHSTANDING VOLTAGE	MIL/202H: Test Method no. : 301
11	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DIELECTRIC WITHSTANDING VOLTAGE	MIL/PRF/55182H:: Method no. : 4.8.12
12	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DIELECTRIC WITHSTANDING VOLTAGE (AC)	MIL/PRF/39017G::Method : 4.8.12
13	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DIMENSION VERIFICATION	JSS 50401 (Test No. 13.1.2)
14	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DIMENSION VERIFICATION	JSS 50402 (Test No. 13.1.2)
15	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DIMENSION VERIFICATION	MIL/PRF/39017G::Method : 4.8.1
16	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DIMENSION VERIFICATION	MIL/PRF/55182H:: Method : 4.8.1
17	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	FINAL DC RESISTANCE MEASUREMENT (SCREENING TEST)	JSS 50115 : 1999; TEST NO 13.2

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18	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INITIAL DC RESISTANCE MEASUREMENT (SCREENING TEST)	JSS 50115
19	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	IS 9437:PART 2 & 3; Method no. : 8.4.3
20	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	IS 8909: PART 2 & 3; Method no. : 8.3.2
21	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	IS 9437 PART 1: Method no. : 8.4.3
22	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	JSS 50101:1996; Clause 17
23	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	JSS 50401 (Test No. 13.4)
24	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	JSS 50402 (Test No. 13.4)
25	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	JSS 50403 (Test No. 13.4)
26	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	MIL/PRF/39017G; Method no. : 4.8.13

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27	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTANCE	MIL/PRF/55182H; Method no. : 4.8.13
28	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	INSULATION RESISTORS	MIL STD 202H: Method no. : 302
29	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	IS 5786 PART 1 :Method no. : 8.6
30	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	IS 8908:1978 PART 2 & 3; Method no. : 8.6
31	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	IS 9437:PART2 & 3; Method no. : 8.6
32	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	JSS 50101 (Test No. 13)
33	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	JSS 50101: TEST NO 13
34	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	JSS 50401 (Test No. 13.17)
35	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	JSS 50402 (Test No. 13.17)

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36	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	JSS 50403 (Test No. 13.17)
37	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	MIL STD 202 H; Method no. : 108
38	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	MIL/PRF/39017G; Method no. : 4.8.18
39	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	MIL/PRF/55182H; Method no. : 4.8.18
40	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	MIL/PRF/55182H; Method no. : 4.8.18
41	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	LIFE ELECTRICAL	MIL/PRF/55182H; Method no. : 4.8.18
42	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST	IS 5786 PART 1: Method no. : 8.3.6
43	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST	IS 8909 PART 2 & 3 : Method no. : 8.3.6
44	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST	IS 9437: PART 2 & 3; Method no. : 8.3.7

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45	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST	JSS 50401 (Test No. 13.19)
46	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST	JSS 50402 (Test No. 13.19)
47	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST	JSS 50403 (Test No. 13.19)
48	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST	MIL/PRF/39017G: Method no. : 4.8.8
49	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST	MIL/PRF/55182H: Method no. : 4.8.3
50	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	OVERLOAD TEST (SCREENING TEST)	JSS 50115
51	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	PERCENT DEFECTIVE ALLOWABLE (SCREENING TEST)	JSS 50115
52	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	POWER CONDITION (SCREENING TEST)	JSS 50115
53	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	IS 5786 PART 1: Method no. : 8.4.4.2

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54	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	IS 8909 PART 2 & 3; Method no. : 8.4.6
55	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	IS 9001 PART 9: Method no. : 7
56	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	IS 9437: PART 2 & 3; Method no. : 8.4.4.2
57	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	JSS 50101 (Test No. 15)
58	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	JSS 50401 (Test No. 13.22)
59	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	JSS 50402
60	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	JSS 50403 (Test No. 13.22)
61	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	MIL STD 202H: Test Method no. : 210F
62	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	MIL/PRF/39017G: Method no. : 4.8.14

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63	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLDERING HEAT	MIL/PRF/55182H: Method no. : 4.8.14
64	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENT	IS 9000 PART 20: Method no. : 7.1
65	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENTS	IS 9001 (PART 5)
66	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENTS	JSS 50101 (Test No. 16)
67	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENTS	JSS 50401 (Test No. 13.21)
68	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENTS	JSS 50402 (Test No. 13.21)
69	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENTS	JSS 50403 (Test No. 13.21)
70	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENTS	MIL STD 202H: Test Method no. : 215K
71	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENTS	MIL/PRF/39017G :Method : 4.8.11

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72	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	RESISTANCE TO SOLVENTS	MIL/PRF/55182H: Method no. : 4.8.8
73	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	ROBUSTNESS OF TERMINATION	IS 5786 PART 1; Method : 8.4.3
74	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	ROBUSTNESS OF TERMINATION	IS 8909 PART 2 & 3 :Method no. : 8.4.5
75	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	ROBUSTNESS OF TERMINATION	IS 9437: PART 2 & 3; Method no. : 8.4.4
76	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	ROBUSTNESS OF TERMINATION	JSS 50101 (Test No. 17)
77	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	ROBUSTNESS OF TERMINATION	JSS 50401
78	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	ROBUSTNESS OF TERMINATION	JSS 50401 (Test No. 13.8)
79	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	ROBUSTNESS OF TERMINATION	MIL/PRF/39017G; Method no. : 4.8.9
80	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	ROBUSTNESS OF TERMINATION	MIL/PRF/55182H; Method : 4.8.11

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81	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	IS 5786 PART 1: Method no. : 8.3.4
82	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	IS 8909 PART 2 & 3: Method : 8.3.4
83	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	IS 9437 PART 2 & 3 : Method : 8.3.5
84	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	JSS 50401 (Test No. 13.24)
85	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	JSS 50402 (Test No. 13.24)
86	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	JSS 50403 (Test No. 13.8)
87	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	MIL/PRF/39017G; Method : 4.8.5
88	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	MIL/PRF/55182H; Method : 4.8.9
89	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COEFFICIENT OF RESISTANCE	MIL/PRF/55342H ; Method no. : 4.8.10

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90	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE RISE	IS 5786 PART 1: Method : 8.3.5
91	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE RISE	IS 8909 PART 2 & 3: Method : 8.3.5
92	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE RISE	IS 9437 : PART 2 & 3; Method : 8.3.6
93	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE RISE	JSS 50401 (Test No. 13.25)
94	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE RISE	JSS 50402 (Test No. 13.25)
95	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE RISE	JSS 50403 (Test No. 13.25)
96	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VISUAL EXAMINATION (SCREENING TEST)	JSS 50115
97	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VISUAL EXAMINATION (VERIFICATION OF WORKMANSHIP AND FINISH)	JSS 40401 (Test No. 13.1.1)
98	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VISUAL EXAMINATION (VERIFICATION OF WORKMANSHIP AND FINISH)	JSS 50402 (Test No. 13.1.1)

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99	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VISUAL EXAMINATION (VERIFICATION OF WORKMANSHIP AND FINISH)	JSS 50403 (Test No. 13.1.1)
100	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VISUAL EXAMINATION (VERIFICATION OF WORKMANSHIP AND FINISH)	JSS 50461 (Test No. 13.1.1)
101	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VISUAL EXAMINATION (VERIFICATION OF WORKMANSHIP AND FINISH)	MIL/PRF/39017G: Method no. : 4.8.1
102	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VISUAL EXAMINATION (VERIFICATION OF WORKMANSHIP AND FINISH)	MIL/PRF/55182H: Method : 4.8.1
103	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VOLTAGE PROOF	IS 5786: Method : 8.3.3
104	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VOLTAGE PROOF	IS 9437:, Method : 8.3.3
105	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VOLTAGE PROOF TEST	IS 8909 PART 2 & 3" Method : 8.3.3
106	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VOLTAGE PROOF TEST	JSS 50401 (Test No. 13.3)
107	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VOLTAGE PROOF TEST	JSS 50402 (Test No. 13.3)

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108	ELECTRONICS-ELECTRONIC COMPONENTS & EQUIPMENT SUB ASSEMBLIES	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	VOLTAGE PROOF TEST	JSS 50403 (Test No. 13.3)
109	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	THERMAL SHOCK	MIL/PRF/39017G; Method No: 4.8.4
110	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	IS 9000 PART 4: Method : 8.5
111	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	JSS 50401 (Test No. 13.16)
112	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	JSS 50402 (Test No. 13.16)
113	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	JSS 50403 (Test No. 13.16)
114	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DRY HEAT	IS 5786 PART 1: Method no : 8.5.1.2
115	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DRY HEAT	IS 9000 PART 3 : Method no : 4
116	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DRY HEAT	JSS 50101 (Test No. 22)
117	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DRY HEAT	MIL STD 202H; Test Method no: 104
118	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	IS 8909 PART 2 & 3 : Method no: 8.4.6
119	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	IS 5786 PART 1: Method no: 8.4.4.1
120	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	IS 9000: 1979 PART 20; Method no: 4

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121	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	IS 9000:1981 PART 18; Method no: 8.4.6
122	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	IS 9001 : 1981 PART 9; Method no: 4
123	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	IS 9437 : 1980 PART 2 & 3 ; Method no: 9.4.5.1
124	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	JSS 50101 (Test No. 19)
125	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	JSS 50401 (Test No. 13.6)
126	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	JSS 50402 (Test No. 13.6)
127	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	JSS 50403 (Test No. 13.6)
128	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	MIL STD 202H; Test Method no: 208H
129	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	MIL/PRF/39017G; Method no: 4.8.10
130	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	SOLDERABILITY	MIL/PRF/55182H; Method no: 4.8.7
131	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COLD	IS 9000 PART 2: Method : 4
132	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COLD	IS 5786 PART 1: Method : 8.5.1.4
133	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COLD	IS 9437 PART 2 & 3: Method : 8.5.1.4
134	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COLD	JSS 50101 (Test No. 21)

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135	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COLD	JSS 50403 (Test No. 13.15.7)
136	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE COLD	MIL STD 202H
137	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE CYCLING (SCREENING TEST)	JSS 50115
138	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	THERMAL SHOCK	JSS 50461
139	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	THERMAL SHOCK	MIL STD 202H: Test Method No: 107G
140	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	IS 9437 PART 2 & 3 : Method : 8.5
141	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	IS 5786 PART 1:: Method : 8.5.2
142	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	IS 8909 PART 2 & 3 : Method : 8.5.2
143	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	JSS 50101 (Test No. 7)
144	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DAMP HEAT STEADY STATE	MIL/PRF/202H:: Test Method no : 103B
145	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DRY HEAT	IS 8909 PART 2 & 3: Method no : 8.5.1.2
146	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	DRY HEAT	IS 9437 PART 2 & 3 : Method no : 8.5.1.2
147	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE CYCLING	IS 5786 PART 1: Method no: 8.5.1.4
148	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE CYCLING	IS 8909 PART 2 & 3 : Method no: 8.4.9

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149	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE CYCLING	IS 9000 PART 14: Method no: N
150	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE CYCLING	IS 9437 PART 2 & 3 : Method No: 8.5.3
151	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE CYCLING	JSS 50101 (Test No. 20)
152	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	TEMPERATURE CYCLING	JSS 50401 (Test No. 13.14)
153	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	THERMAL SHOCK	MIL STD 202H: Test Method No: 107G
154	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	THERMAL SHOCK	MIL/PRF/55182H; Method No: 4.8.2
155	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	THERMAL SHOCKS	IS 9437 PART 2 & 3 : Method No: 8.4.8
156	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	ALL TYPES OF RESISTORS EXCEPT CHIP RESISTORS	THERMAL SHOCKS	IS 8909 PART 2 & 3 : Method No: 8.4.9